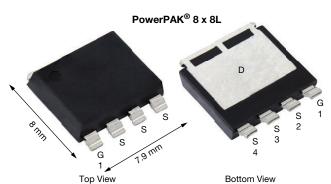


N-Channel 40 V (D-S) 175 °C MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	40			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.00052			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.00074			
Q _g typ. (nC)	99			
I _D (A) ^a	608			
Configuration	Single			

FEATURES

- TrenchFET® Gen IV power MOSFET
- Fully lead (Pb)-free device
- Very low R_{DS} x Q_g figure of merit (FOM)
- 50 % smaller footprint than D2PAK (TO-263)
- 100 % R_a and UIS tested
- · Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

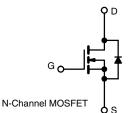


COMPLIANT

HALOGEN FREE

APPLICATIONS

- · Synchronous rectification
- OR-ing
- Motor drive control
- · Battery management



ORDERING INFORMATION	
Package	PowerPAK 8 x 8L
Lead (Pb)-free and halogen-free	SIJH400E-T1-GE3

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	40	V	
Gate-source voltage		V _{GS}	+20, -16	v	
Continuous drain current (T _J = 175 °C)	T _C = 25 °C		608		
	T _C = 70 °C		509		
	T _A = 25 °C	ID	57 b		
	T _A = 70 °C		47 b	Α	
Pulsed drain current (t = 100 μs)		I _{DM}	800	^	
Continuous source-drain diode current	T _C = 25 °C		350		
	T _A = 25 °C	l _s	3 p		
Single pulse avalanche current	rent L = 0.1 mH		82		
Single pulse avalanche energy	L = 0.1 IIII	E _{AS}	338	mJ	
Maximum power dissipation	T _C = 25 °C		385		
	T _C = 70 °C	В	269	w	
	T _A = 25 °C	P _D	3.3 ^b	VV	
	T _A =70 °C		2.3 ^b		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +175	°C	
Soldering recommendations (peak temperature) ^c			260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient ^b	Steady state	R _{thJA}	36	45	°C/W	
Maximum junction-to-case (drain)	Steady state	R _{thJC}	0.28	0.39	C/VV	

Notes

a. $T_C = 25$ °C

b. Surface mounted on 1" x 1" FR4 board
c. See solder profile (www.vishay.com/doc?73257). The PowerPAK 8 x 8L is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
d. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components



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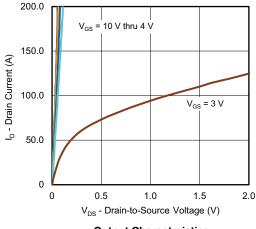
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static			I.		•		
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$		-	24	-	mV/°(
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-7.8	-		
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.1	-	2.4	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +20, -16$	-	-	100	nA	
Zero gate voltage drain current		V _{DS} = 40 V, V _{GS} =0 V	-	-	1		
	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V, T _J = 70 °C	-	-	15	μA	
Drain-source on-state resistance ^a	_	$V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$	-	0.00041	0.00052	Ω	
	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$	-	0.00058	0.00074		
Forward transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 75 A	-	290	-	S	
Dynamic ^b					•		
Input capacitance	C _{iss}	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz	-	15 050	-	pF	
Output capacitance	C _{oss}		-	3115	-		
Reverse transfer capacitance	C _{rss}		-	240	-		
Total coloraba as a	0	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 20 \text{ A}$ $V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 20 \text{ A}$	-	220	330	nC	
Total gate charge	Q_g		-	99	148		
Gate-source charge	Q_{gs}		-	50	-		
Gate-drain charge	Q_{gd}		-	12	-		
Gate resistance	R_g	f = 1 MHz	0.2	1.1	2.2	Ω	
Turn-on delay time	t _{d(on)}	V_{DD} = 40 V, R_L = 4 Ω , I_D \cong 10 A, V_{GEN} = 10 V, R_g = 1 Ω	-	22	45	-	
Rise time	t _r		-	15	30		
Turn-off delay time	t _{d(off)}		-	90	180		
Fall time	t _f		-	16	35		
Turn-on delay time	t _{d(on)}		-	80	160	ns	
Rise time	t _r	$\begin{split} V_{DD} = 40 \text{ V}, \text{ R}_L = 4 \Omega, \text{ I}_D &\cong 10 \text{ A}, \\ V_{GEN} = 4.5 \text{ V}, \text{ R}_g = 1 \Omega \end{split}$	-	125	250		
Turn-off delay time	t _{d(off)}		-	95	190		
Fall time	t _f		-	80	160		
Drain-Source Body Diode Characteristi	cs						
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	350	۸	
Pulse diode forward current	I _{SM}		-	-	800	Α	
Body diode voltage	V_{SD}	I _S = 10 A, V _{GS} = 0 V	-	0.7	1.1	V	
Body diode reverse recovery time	t _{rr}		-	75	150	ns	
Body diode reverse recovery charge	Q _{rr}		-	155	310	nC	
Reverse recovery fall time	t _a	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	46	-		
Reverse recovery rise time	t _b		-	29	-	ns	

Notes

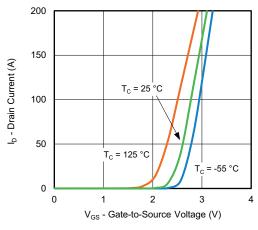
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

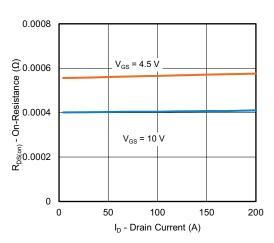




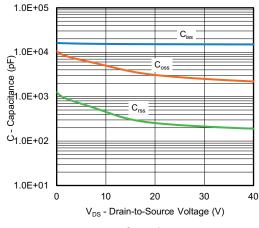
Output Characteristics



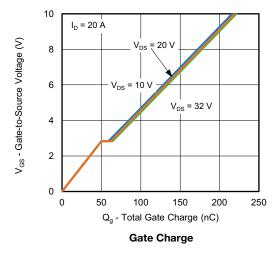
Transfer Characteristics

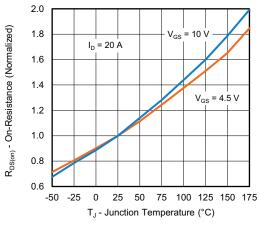


On-Resistance vs. Drain Current and Gate Voltage



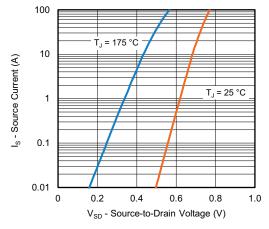
Capacitance



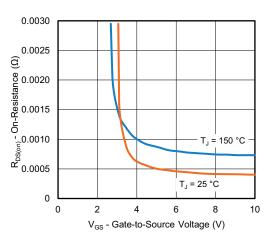


On-Resistance vs. Junction Temperature

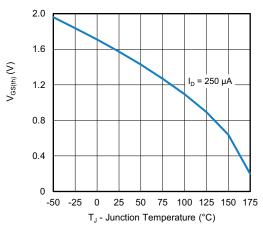




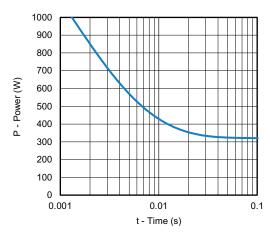
Source-Drain Diode Forward Voltage



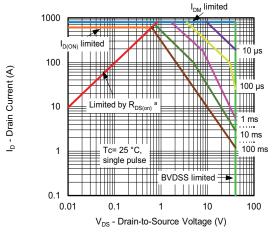
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Case

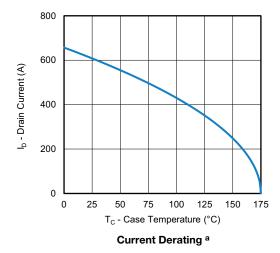


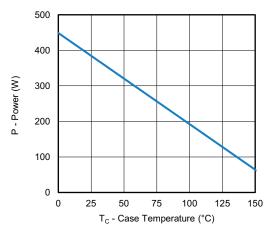
Safe Operating Area, Junction-to-Case

Note

a. $V_{GS} > minimum V_{GS}$ at which $R_{DS(on)}$ is specified





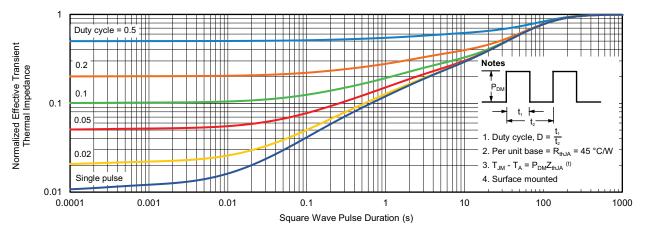


Power, Junction-to-Case

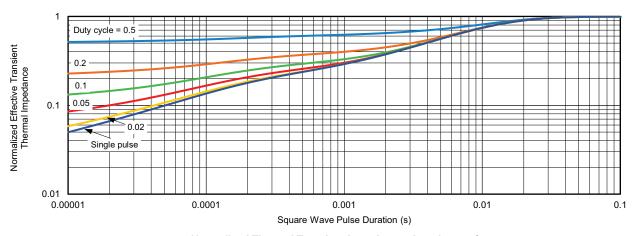
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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